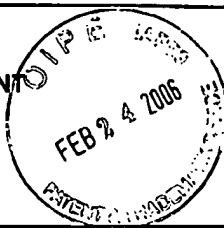


<b>LIST OF REFERENCES CITED BY APPLICANT</b> (Use several sheets if necessary)		<b>ATTY. DOCKET NO.</b> 100325.0193US	<b>SERIAL NO.</b> 10/528435
	<b>APPLICANT</b> John Mak		
	<b>371 DATE</b> June 6, 2005	<b>GROUP</b> 3744	

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/N.Y./	AA	US 2002/0065446 A1	5/30/2002	Wilkinson et al.	585	802	10/26/2001
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							YES	NO
/N.Y./	JJ	WO 03/095913 A1	11/20/2003	WIPO Publication	F25J	3/00	YES	
/N.Y./	KK	732141 <i>AU</i>	4/12/2001	C. L. Rambo et al.	F25J	003/02		
	LL							
	MM							
	NN							

<b>OTHER REFERENCES</b> (Including Author, Title, Date, Pertinent Pages, Etc.)	
/N.Y./	OO R. N. Pittman et al. "Next Generation Processes for NGL/LPG Recovery" Proceeding of the Seventy-Seventh GPA Annual Convention
<b>EXAMINER</b>	<b>DATE CONSIDERED</b>
/Natasha Young/	02/28/2008
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	